



M24M01-HR M24M01-R, M24M01-W

1 Mbit serial I²C bus EEPROM

Features

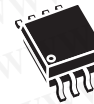
- Support I²C bus modes:
 - 1 MHz Fast-mode Plus
 - 400 kHz Fast mode
 - 100 kHz Standard mode
- M24M01-HR:
1 MHz, 400 kHz, or 100 kHz I²C clock frequency
- M24M01-R, M24M01-W:
400 kHz, or 100 kHz I²C clock frequency
- Single supply voltage:
 - 1.8 V to 5.5 V
 - 2.5 V to 5.5 V
- Hardware write control
- Byte and Page Write (up to 256 bytes)
- Random and Sequential Read modes
- Self-timed programming cycle
- Automatic address incrementing
- Enhanced ESD/Latch-Up protection
- More than 1 million Write cycles
- More than 40-year data retention
- Packages
 - ECOPACK® (RoHS compliant)



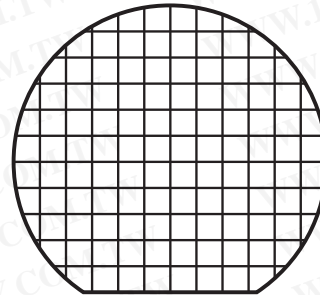
WLCSP (CS)



SO8 (MN)
150 mils width



SO8 (MW)
208 mils width



Wafer

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Description

The M24M01-HR, M24M01-R and M24M01-W are I²C-compatible electrically erasable programmable memory (EEPROM) devices organized as 128 Kb × 8 bits.

The I²C bus is a two-wire serial interface, comprising a bidirectional data line and a clock line. The devices carry a built-in 4-bit device type identifier code (1010) in accordance with the I²C bus definition.

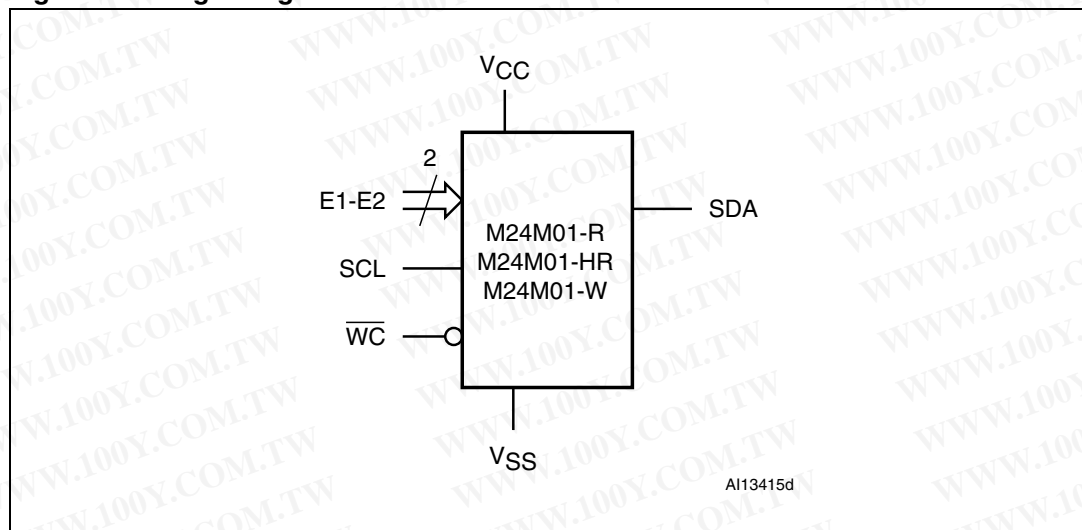
The M24M01-HR, M24M01-R and M24M01-W behave as slaves in the I²C protocol, with all memory operations synchronized by the serial clock. Read and Write operations are generated by the bus master and initiated by a Start condition, followed by the device select code, address bytes and data bytes. Data transfers are terminated by a Stop condition after an Ack for Write, and after a NoAck for Read.

When writing data to the memory, the device inserts an acknowledge bit during the 9th bit time, following the bus master's 8-bit transmission. When data is read by the bus master, the bus master acknowledges the receipt of the data byte in the same way.

The M24M01-HR, M24M01-R and M24M01-W are delivered in SO8 packages and the M24M01-R is also available in wafer form (see [Table 21: Available M24M01-x products \(package, voltage range, frequency, temperature grade\)](#) for details).

Caution: As EEPROM cells lose their charge (and so their binary value) when exposed to ultra violet (UV) light, EEPROM dice delivered in wafer form by STMicroelectronics must never be exposed to UV light.

Figure 1. Logic diagram

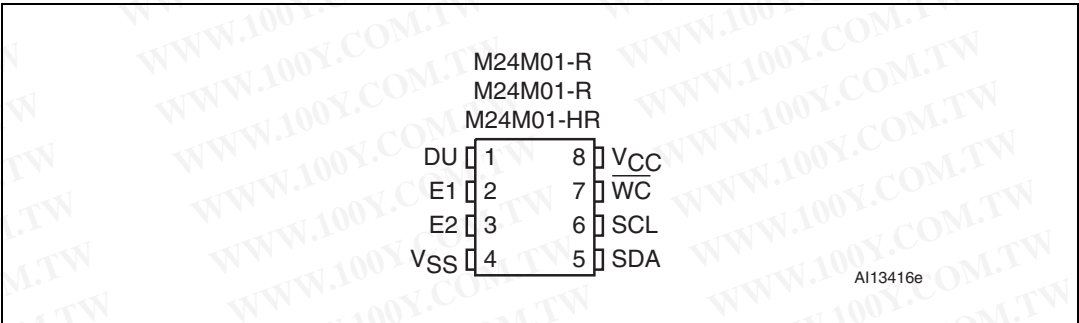


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Table 1. Signal names

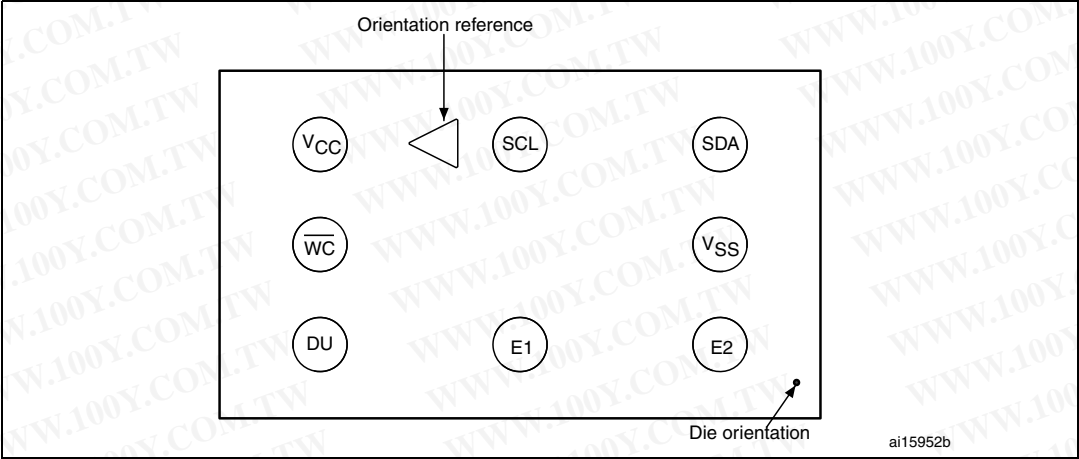
Signal name	Function	Direction
E1, E2	Chip Enable	Input
SDA	Serial Data	I/O
SCL	Serial Clock	Input
\overline{WC}	Write Control	Input
V_{CC}	Supply voltage	
V_{SS}	Ground	

Figure 2. SO connections



- See [Section 7: Package mechanical data](#) for package dimensions, and how to identify pin-1.
- DU = Don't use.

Figure 3. WLCSP8 connections



- NC = not connected internally.
- DU = Don't use.

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2 Signal description

2.1 Serial Clock (SCL)

This input signal is used to strobe all data in and out of the device. In applications where this signal is used by slave devices to synchronize the bus to a slower clock, the bus master must have an open drain output, and a pull-up resistor must be connected from Serial Clock (SCL) to V_{CC} . (Figure 6 indicates how the value of the pull-up resistor can be calculated). In most applications, though, this method of synchronization is not employed, and so the pull-up resistor is not necessary, provided that the bus master has a push-pull (rather than open drain) output.

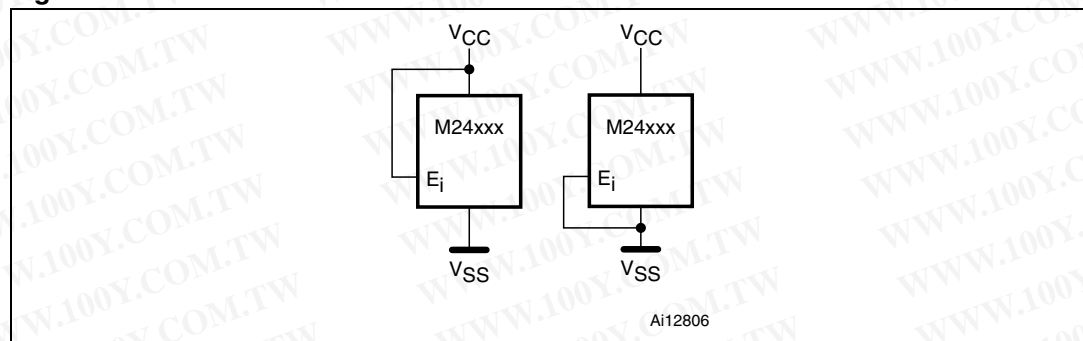
2.2 Serial Data (SDA)

This bidirectional signal is used to transfer data in or out of the device. It is an open drain output that may be wire-OR'ed with other open drain or open collector signals on the bus. A pull up resistor must be connected from Serial Data (SDA) to V_{CC} . (Figure 6 indicates how the value of the pull-up resistor can be calculated).

2.3 Chip Enable (E1, E2)

These input signals are used to set the value that is to be looked for on the two bits (b3, b2) of the 7-bit device select code. These inputs must be tied to V_{CC} or V_{SS} , to establish the device select code as shown in Figure 4. When not connected (left floating), these inputs are read as low (0,0).

Figure 4. Device select code



2.4 Write Control (\overline{WC})

This input signal is useful for protecting the entire contents of the memory from inadvertent write operations. Write operations are disabled to the entire memory array when Write Control (\overline{WC}) is driven high. When unconnected, the signal is internally read as V_{IL} , and Write operations are allowed.

When Write Control (\overline{WC}) is driven high, device select and address bytes are acknowledged, Data bytes are not acknowledged.

2.5 V_{SS} ground

V_{SS} is the reference for the V_{CC} supply voltage.

2.6 Supply voltage (V_{CC})

2.6.1 Operating supply voltage V_{CC}

Prior to selecting the memory and issuing instructions to it, a valid and stable V_{CC} voltage within the specified [$V_{CC}(\min)$, $V_{CC}(\max)$] range must be applied (see [Table 7](#)). In order to secure a stable DC supply voltage, it is recommended to decouple the V_{CC} line with a suitable capacitor (usually of the order of 10 nF to 100 nF) close to the V_{CC}/V_{SS} package pins.

This voltage must remain stable and valid until the end of the transmission of the instruction and, for a write instruction, until the completion of the internal write cycle (t_W).

2.6.2 Power-up conditions

The V_{CC} voltage has to rise continuously from 0 V up to the minimum V_{CC} operating voltage defined in [Table 7](#) and the rise time must not vary faster than 1 V/ μ s.

2.6.3 Device reset

In order to prevent inadvertent write operations during power-up, a power-on-reset (POR) circuit is included. At power-up, the device does not respond to any instruction until V_{CC} has reached the internal reset threshold voltage. This threshold is lower than the minimum V_{CC} operating voltage defined in [Table 7](#), and [Table 8](#). When V_{CC} passes over the POR threshold, the device is reset and enters the Standby Power mode. The device must not be accessed until V_{CC} reaches a valid and stable V_{CC} voltage within the specified [$V_{CC}(\min)$, $V_{CC}(\max)$] range defined in [Table 7](#).

In a similar way, during power-down (continuous decrease in V_{CC}), as soon as V_{CC} drops below the power-on-reset threshold voltage, the device stops responding to any instruction sent to it.

2.6.4 Power-down conditions

During power-down (continuous decrease in V_{CC}), the device must be in the Standby Power mode (mode reached after decoding a Stop condition, assuming that there is no internal write cycle in progress).

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Figure 5. M24M01-R/M24M01-W – Maximum R_{bus} value versus bus parasitic capacitance (C_{bus}) for an I²C bus at maximum frequency $f_C = 400$ kHz

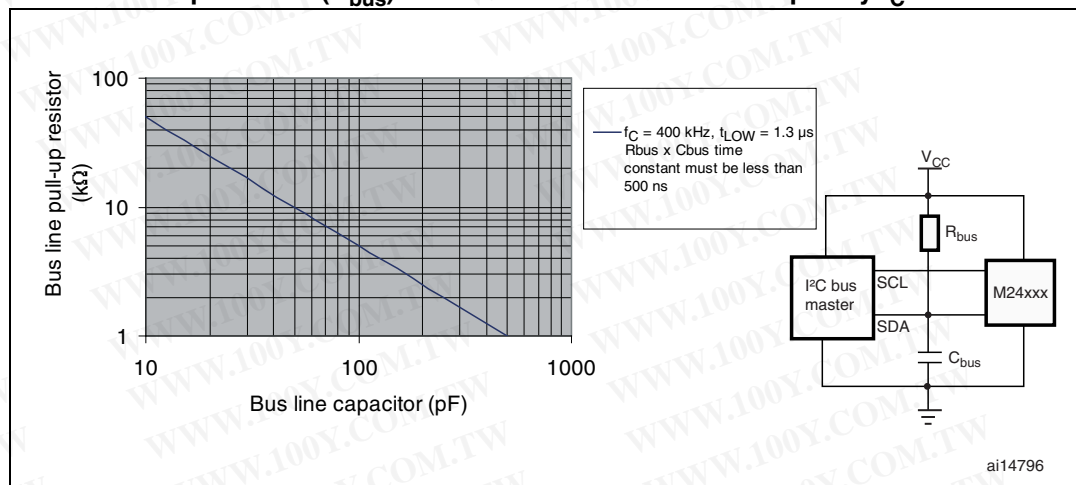
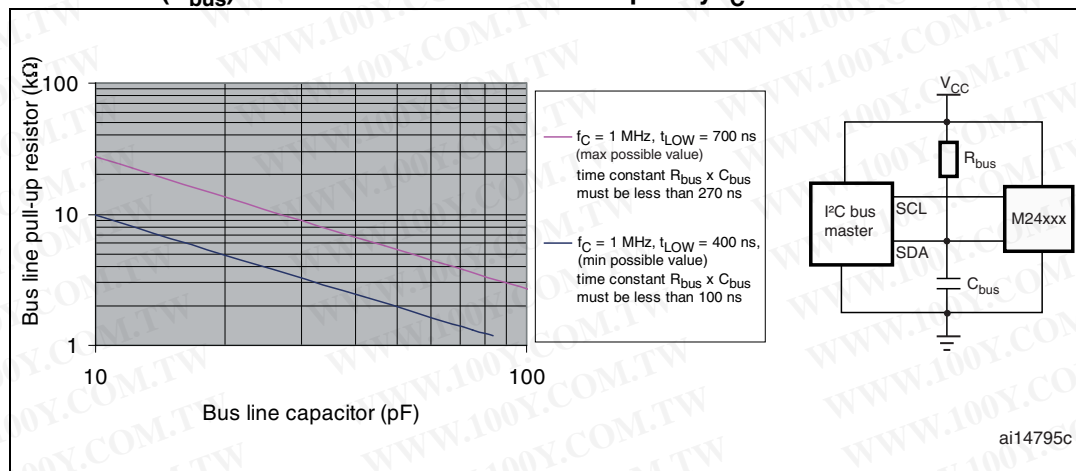


Figure 6. M24M01-HR – Maximum R_{bus} value versus bus parasitic capacitance (C_{bus}) for an I²C bus at maximum frequency $f_C = 1$ MHz



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Figure 7. I²C bus protocol

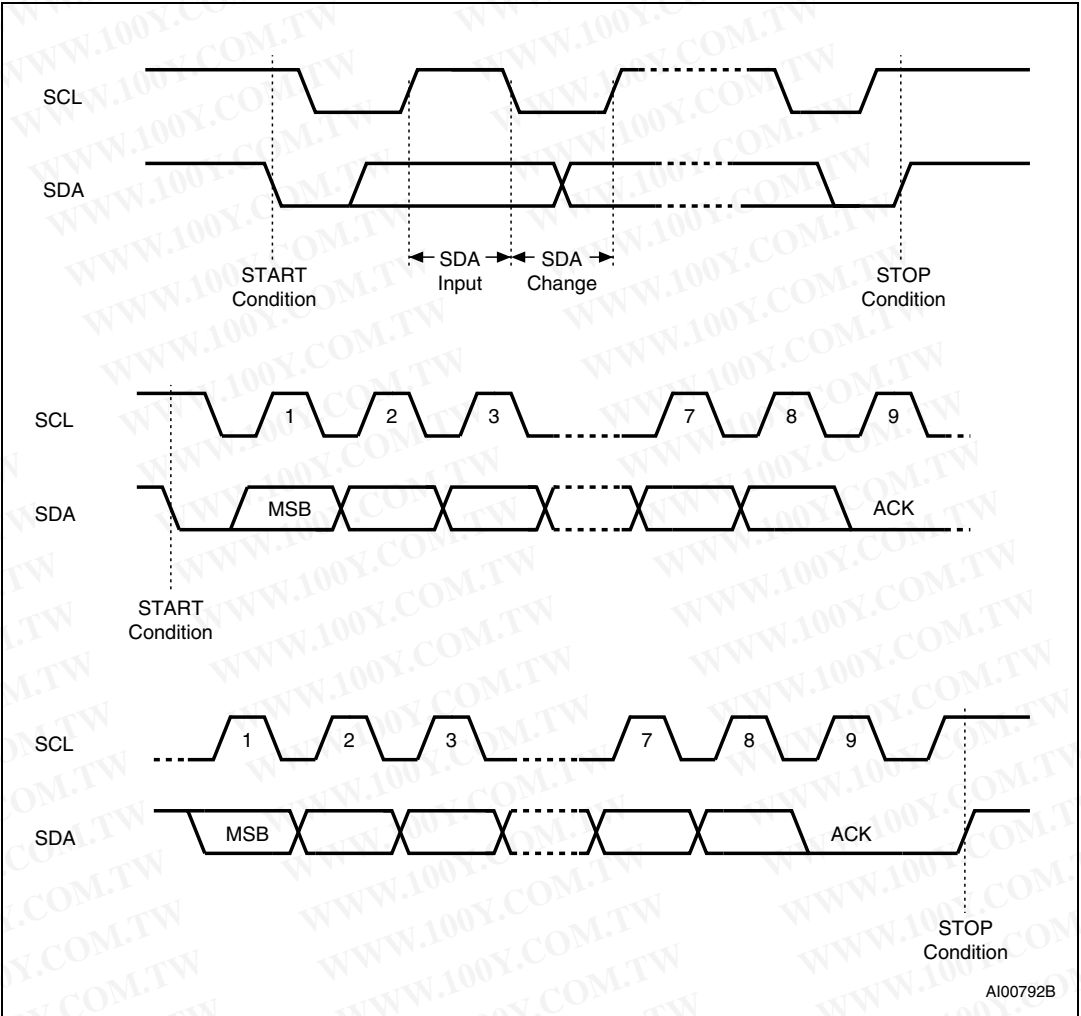


Table 2. Device select code

	Device type identifier ⁽¹⁾				Chip Enable address ⁽²⁾		A16	R \overline{W}
	b7	b6	b5	b4	b3	b2	b1	b0
Device select code	1	0	1	0	E2	E1	A16	R \overline{W}

1. The most significant bit, b7, is sent first.
2. E1 and E2 are compared against the respective external pins on the memory device.

Table 3. Most significant address byte

b15	b14	b13	b12	b11	b10	b9	b8
-----	-----	-----	-----	-----	-----	----	----

Table 4. Least significant address byte

b7	b6	b5	b4	b3	b2	b1	b0
----	----	----	----	----	----	----	----

3 Device operation

The device supports the I²C protocol. This is summarized in [Figure 7](#). Any device that sends data on to the bus is defined to be a transmitter, and any device that reads the data to be a receiver. The device that controls the data transfer is known as the bus master, and the other as the slave device. A data transfer can only be initiated by the bus master, which will also provide the serial clock for synchronization. The M24M01-R, M24M01-HR and M24M01-W devices are always slaves in all communications.

3.1 Start condition

Start is identified by a falling edge of Serial Data (SDA) while Serial Clock (SCL) is stable in the high state. A Start condition must precede any data transfer instruction. The device continuously monitors (except during a Write cycle) Serial Data (SDA) and Serial Clock (SCL) for a Start condition, and will not respond unless one is given.

3.2 Stop condition

Stop is identified by a rising edge of Serial Data (SDA) while Serial Clock (SCL) is stable and driven high. A Stop condition terminates communication between the device and the bus master. A Read instruction that is followed by NoAck can be followed by a Stop condition to force the device into the Standby mode. A Stop condition at the end of a Write instruction triggers the internal EEPROM Write cycle.

3.3 Acknowledge bit (ACK)

The acknowledge bit is used to indicate a successful byte transfer. The bus transmitter, whether it be bus master or slave device, releases Serial Data (SDA) after sending eight bits of data. During the 9th clock pulse period, the receiver pulls Serial Data (SDA) low to acknowledge the receipt of the eight data bits.

3.4 Data input

During data input, the device samples Serial Data (SDA) on the rising edge of Serial Clock (SCL). For correct device operation, Serial Data (SDA) must be stable during the rising edge of Serial Clock (SCL), and the Serial Data (SDA) signal must change *only* when Serial Clock (SCL) is driven low.

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3.5 Memory addressing

To start communication between the bus master and the slave device, the bus master must initiate a Start condition. Following this, the bus master sends the device select code, shown in [Table 2](#) (on Serial Data (SDA), most significant bit first).

The device select code consists of a 4-bit device type identifier, and a 2-bit Chip Enable "Address" (E2, E1). To address the memory array, the 4-bit device type identifier is 1010b.

Up to four memory devices can be connected on a single I²C bus. Each one is given a unique 2-bit code on the Chip Enable (E1, E2) inputs. When the device select code is received, the device only responds if the Chip Enable Address is the same as the value on the Chip Enable (E1, E2) inputs.

The 8th bit is the Read/Write bit (\overline{RW}). This bit is set to 1 for Read and 0 for Write operations.

If a match occurs on the device select code, the corresponding device gives an acknowledgment on Serial Data (SDA) during the 9th bit time. If the device does not match the device select code, it deselects itself from the bus, and goes into Standby mode.

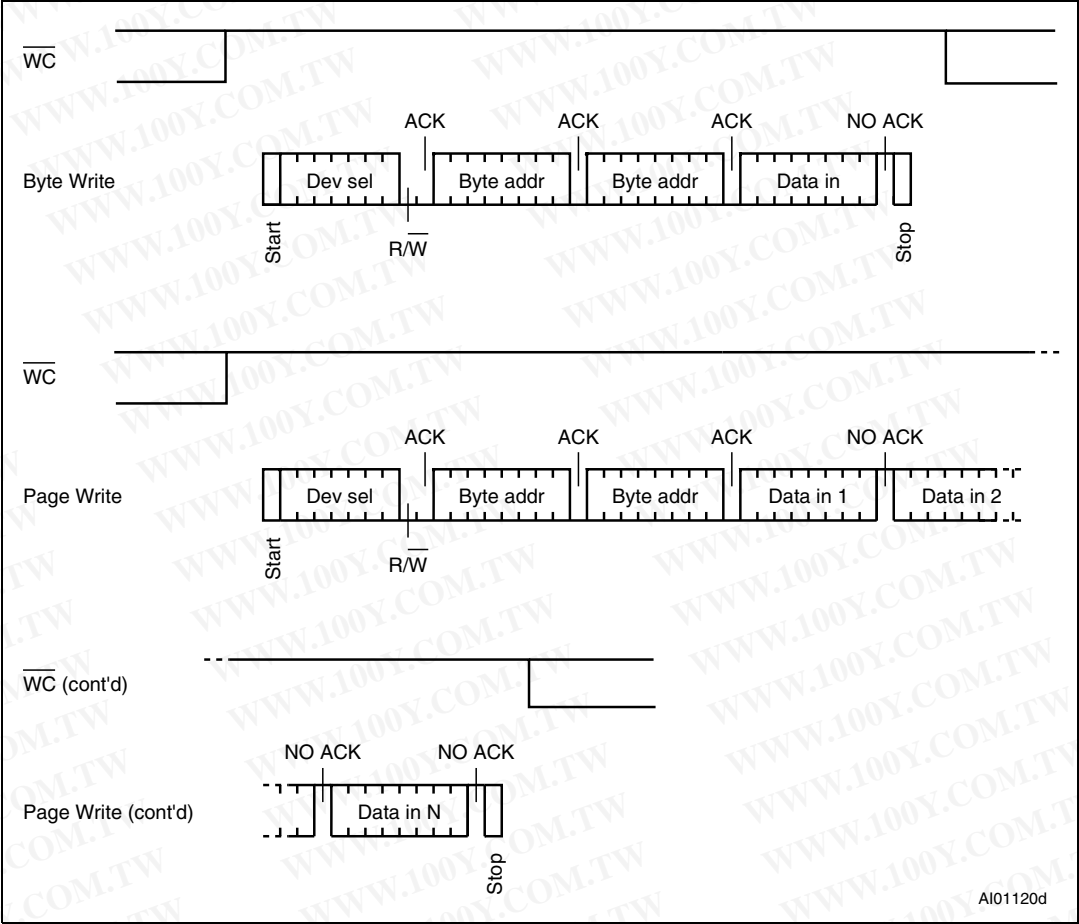
Table 5. Operating modes

Mode	\overline{RW} bit	$\overline{WC}^{(1)}$	Bytes	Initial sequence
Current Address Read	1	X	1	Start, device select, $\overline{RW} = 1$
Random Address Read	0	X	1	Start, device select, $\overline{RW} = 0$, Address
	1	X		reStart, device select, $\overline{RW} = 1$
Sequential Read	1	X	≥ 1	Similar to Current or Random Address Read
Byte Write	0	V_{IL}	1	Start, device select, $\overline{RW} = 0$
Page Write	0	V_{IL}	≤ 256	Start, device select, $\overline{RW} = 0$

1. X = V_{IH} or V_{IL} .

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Figure 8. Write mode sequences with $\overline{WC} = 1$ (data write inhibited)



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3.6 Write operations

Following a Start condition the bus master sends a device select code with the R/\overline{W} bit (R/\overline{W}) reset to 0. The device acknowledges this, as shown in [Figure 9](#), and waits for two address bytes. The device responds to each address byte with an acknowledge bit, and then waits for the data byte.

Writing to the memory may be inhibited if Write Control (\overline{WC}) is driven high. Any Write instruction with Write Control (\overline{WC}) driven high (during a period of time from the Start condition until the end of the two address bytes) will not modify the memory contents, and the accompanying data bytes are *not* acknowledged, as shown in [Figure 8](#).

Each data byte in the memory has a 17-bit address (the most significant bit b16 is in the device select code and the Least Significant Bits b15-b0 are defined in two address bytes). The most significant byte ([Table 3](#)) is sent first, followed by the least significant byte ([Table 4](#)).

When the bus master generates a Stop condition immediately after the Ack bit (in the “10th bit” time slot), either at the end of a Byte Write or a Page Write, the internal memory Write cycle is triggered. A Stop condition at any other time slot does not trigger the internal Write cycle.

After the Stop condition, the delay $t_{w\overline{}}$, and the successful completion of a Write operation, the device's internal address counter is incremented automatically, to point to the next byte address after the last one that was modified.

During the internal Write cycle, Serial Data (SDA) is disabled internally, and the device does not respond to any requests.

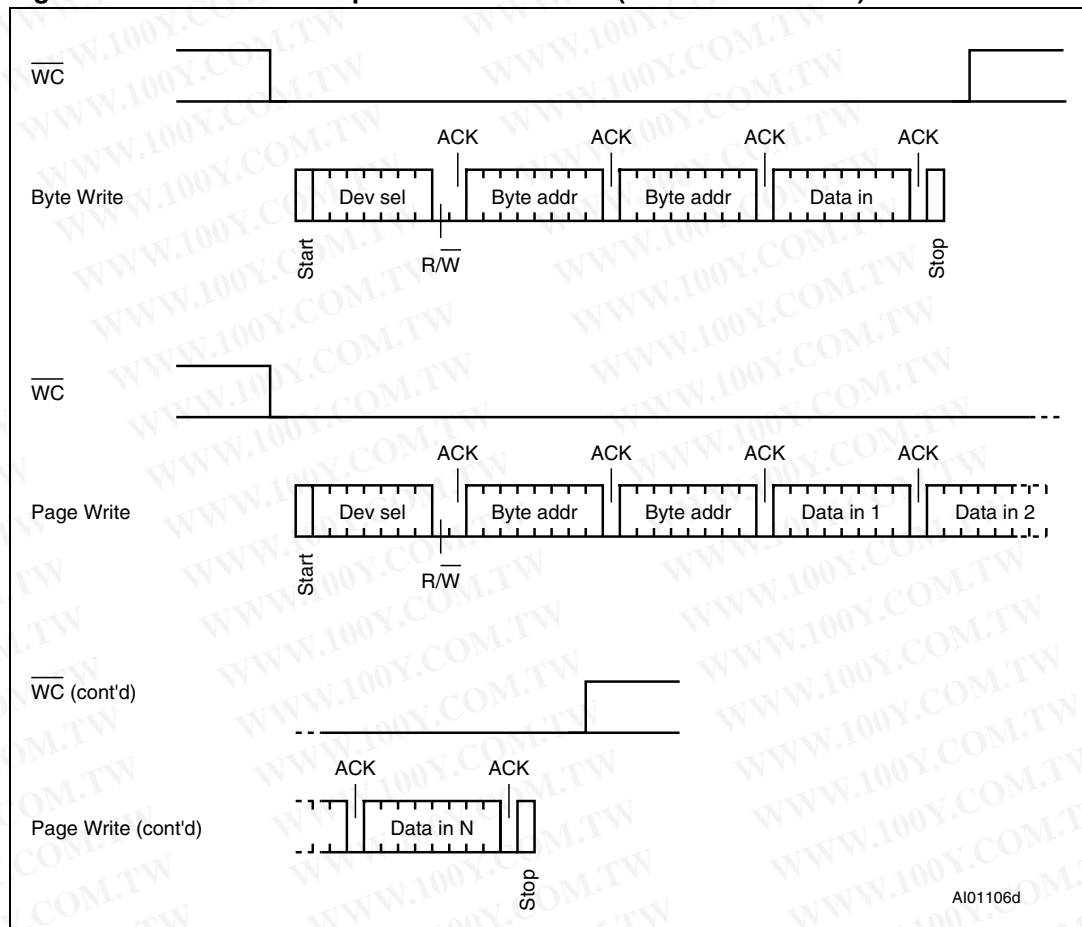
3.7 Byte Write

After the device select code and the address bytes, the bus master sends one data byte. If the addressed location is Write-protected, by Write Control (\overline{WC}) being driven high, the device replies with NoAck, and the location is not modified. If, instead, the addressed location is not Write-protected, the device replies with Ack. The bus master terminates the transfer by generating a Stop condition, as shown in [Figure 9](#).

3.8 Page Write

The Page Write mode allows up to 256 bytes to be written in a single Write cycle, provided that they are all located in the same 'row' in the memory: that is, the most significant memory address bits, b16-b8, are the same. If more bytes are sent than will fit up to the end of the row, a condition known as 'roll-over' occurs. This should be avoided, as data starts to become overwritten in an implementation dependent way.

The bus master sends from 1 to 256 bytes of data, each of which is acknowledged by the device if Write Control (\overline{WC}) is low. If Write Control (\overline{WC}) is high, the contents of the addressed memory location are not modified, and each data byte is followed by a NoAck. After each byte is transferred, the internal byte address counter (the 8 least significant address bits only) is incremented. The transfer is terminated by the bus master generating a Stop condition.

Figure 9. Write mode sequences with $\overline{WC} = 0$ (data write enabled)

3.9 ECC (error correction code) and Write cycling

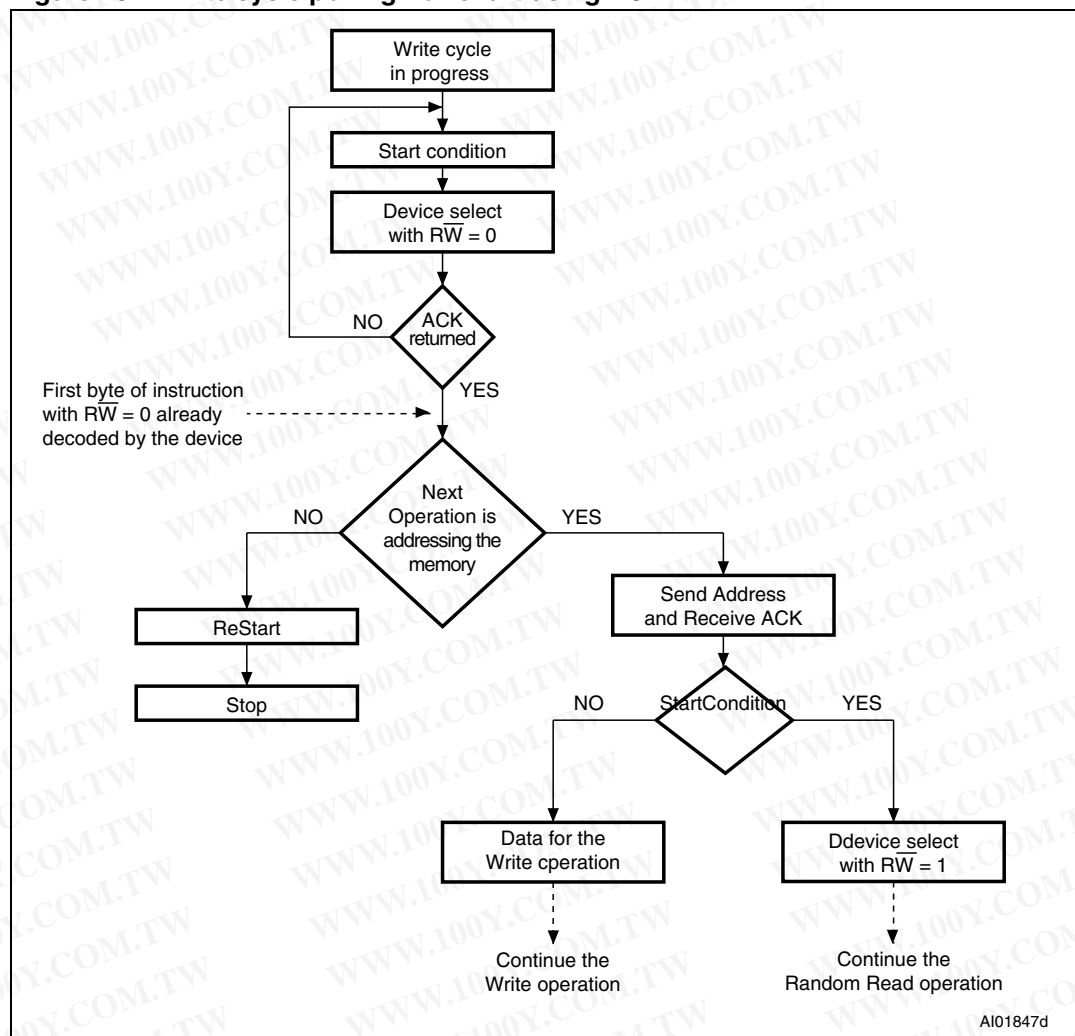
The M24M01-R, M24M01-HR and M24M01-W devices offer an ECC (error correction code) logic which compares each 4-byte word with its six associated EEPROM ECC bits. As a result, if a single bit out of 4 bytes of data happens to be erroneous during a Read operation, the ECC detects it and replaces it by the correct value. The read reliability is therefore much improved by the use of this feature.

Note however that even if a single byte has to be written, 4 bytes are internally modified (plus the ECC word), that is, the addressed byte is cycled together with the three other bytes making up the word. It is therefore recommended to write by packets of 4 bytes in order to benefit from the larger amount of Write cycles.

The M24M01-R, M24M01-HR and M24M01-W devices are qualified at 1 million (1 000 000) Write cycles, using a cycling routine that writes to the device by multiples of 4-byte words.

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Figure 10. Write cycle polling flowchart using ACK



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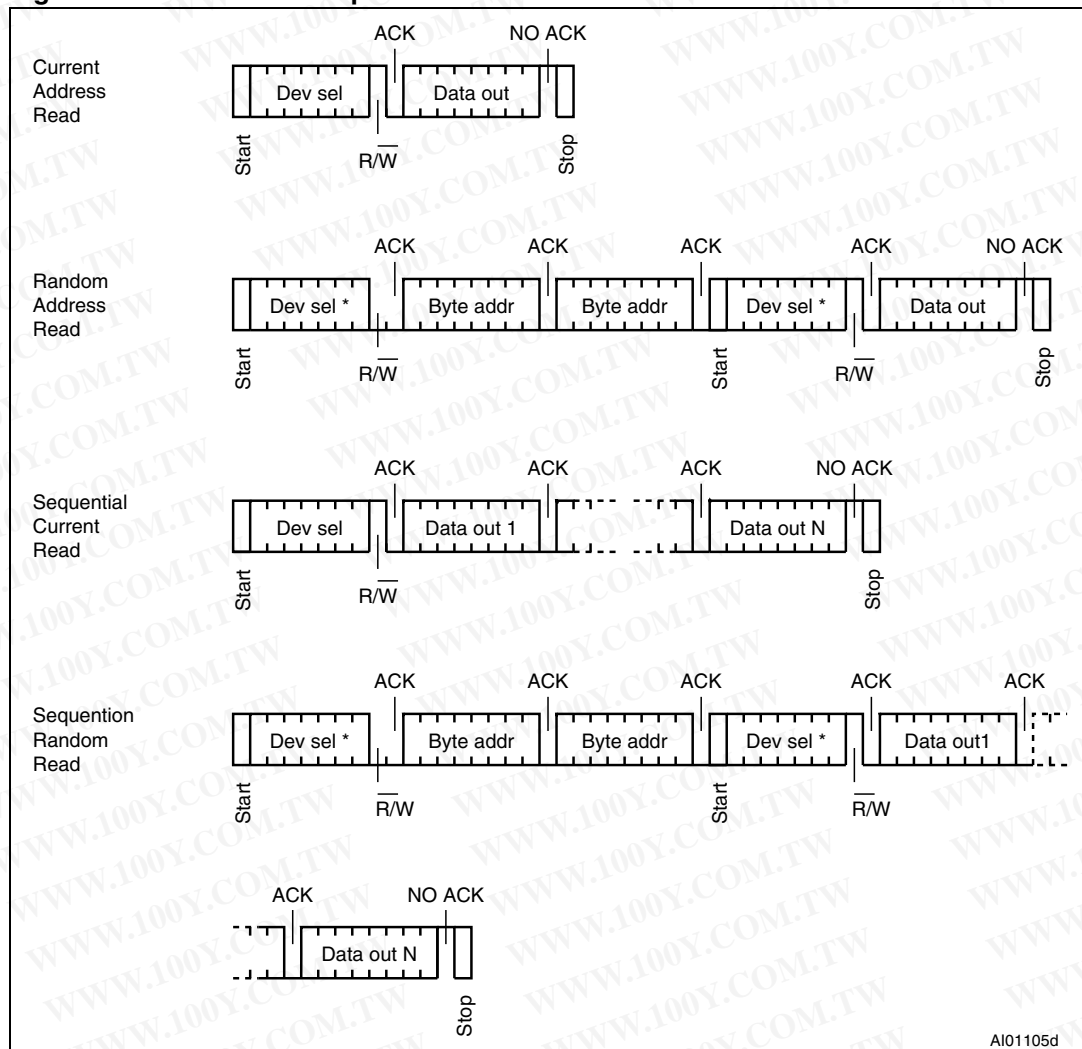
3.10 Minimizing system delays by polling on ACK

During the internal Write cycle, the device disconnects itself from the bus, and writes a copy of the data from its internal latches to the memory cells. The maximum Write time (t_w) is shown in Table 13, but the typical time is shorter. To make use of this, a polling sequence can be used by the bus master.

The sequence, as shown in Figure 10, is:

- Initial condition: a Write cycle is in progress.
- Step 1: the bus master issues a Start condition followed by a device select code (the first byte of the new instruction).
- Step 2: if the device is busy with the internal Write cycle, no Ack will be returned and the bus master goes back to Step 1. If the device has terminated the internal Write cycle, it responds with an Ack, indicating that the device is ready to receive the second part of the instruction (the first byte of this instruction having been sent during Step 1).

Figure 11. Read mode sequences



1. The seven most significant bits of the device select code of a Random Read (in the 1st and 4th bytes) must be identical.

3.11 Read operations

Read operations are performed independently of the state of the Write Control (\overline{WC}) signal. After the successful completion of a Read operation, the device's internal address counter is incremented by one, to point to the next byte address.

3.12 Random Address Read

A dummy Write is first performed to load the address into this address counter (as shown in [Figure 11](#)) but *without* sending a Stop condition. Then, the bus master sends another Start condition, and repeats the device select code, with the \overline{RW} bit set to 1. The device acknowledges this, and outputs the contents of the addressed byte. The bus master must *not* acknowledge the byte, and terminates the transfer with a Stop condition.

3.13 Current Address Read

For the Current Address Read operation, following a Start condition, the bus master only sends a device select code with the \overline{RW} bit set to 1. The device acknowledges this, and outputs the byte addressed by the internal address counter. The counter is then incremented. The bus master terminates the transfer with a Stop condition, as shown in [Figure 11](#), *without* acknowledging the byte.

3.14 Sequential Read

This operation can be used after a Current Address Read or a Random Address Read. The bus master *does* acknowledge the data byte output, and sends additional clock pulses so that the device continues to output the next byte in sequence. To terminate the stream of bytes, the bus master must *not* acknowledge the last byte, and *must* generate a Stop condition, as shown in [Figure 11](#).

The output data comes from consecutive addresses, with the internal address counter automatically incremented after each byte output. After the last memory address, the address counter 'rolls-over', and the device continues to output data from memory address 00h.

3.15 Acknowledge in Read mode

For all Read instructions, the device waits, after each byte read, for an acknowledgment during the 9th bit time. If the bus master does not drive Serial Data (SDA) low during this time, the device terminates the data transfer and switches to its Standby mode.

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4 Initial delivery state

The device is delivered with all the memory array bits set to 1 (each byte contains FFh).

5 Maximum rating

Stressing the device outside the ratings listed in [Table 6](#) may cause permanent damage to the device. These are stress ratings only, and operation of the device at these, or any other conditions outside those indicated in the operating sections of this specification, is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 6. Absolute maximum ratings

Symbol	Parameter	Min.	Max.	Unit
T_A	Ambient operating temperature	-40	130	°C
T_{STG}	Storage temperature	-65	150	°C
T_{LEAD}	Lead temperature during soldering	see note ⁽¹⁾		°C
V_{IO}	Input or output range	-0.50	$V_{CC} + 0.6$	V
I_{OL}	DC output current (SDA = 0)	-	5	mA
V_{CC}	Supply voltage	-0.50	6.5	V
V_{ESD}	Electrostatic discharge voltage (Human Body model) ⁽²⁾	-3000	3000	V

- Compliant with JEDEC Std J-STD-020D (for small body, Sn-Pb or Pb assembly), the ST ECOPACK® 7191395 specification, and the European directive on Restrictions on Hazardous Substances (RoHS) 2002/95/EU.
- AEC-Q100-002 (compliant with JEDEC Std JESD22-A114A, C1=100pF, R1=1500Ω, R2=500Ω)

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6 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC characteristic tables that follow are derived from tests performed under the measurement conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 7. Operating conditions (M24M01-R and M24M01-HR)

Symbol	Parameter	Min.	Max.	Unit
V_{CC}	Supply voltage	1.8	5.5	V
T_A	Ambient operating temperature	-40	85	°C

Table 8. Operating conditions (M24M01-W)

Symbol	Parameter	Min.	Max.	Unit
V_{CC}	Supply voltage	2.5	5.5	V
T_A	Ambient operating temperature	-40	125	°C

Table 9. AC measurement conditions

Symbol	Parameter	Min.	Max.	Unit
C_L	Load capacitance	100		pF
	Input rise and fall times		50	ns
	Input levels	$0.2V_{CC}$ to $0.8V_{CC}$		V
	Input and output timing reference levels	$0.3V_{CC}$ to $0.7V_{CC}$		V

Figure 12. AC measurement I/O waveform

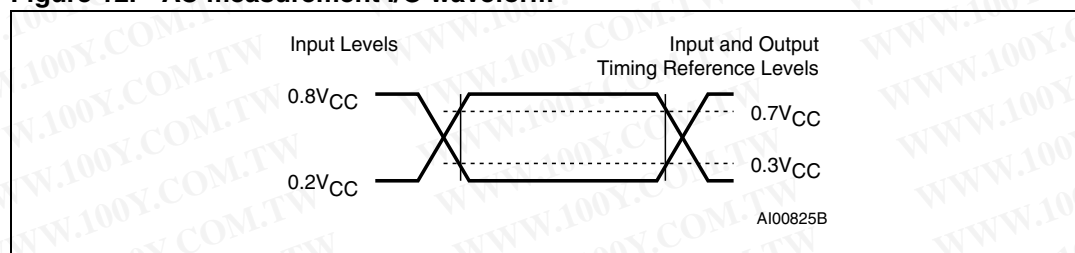


Table 10. Input parameters

Symbol	Parameter ⁽¹⁾	Test condition	Min.	Max.	Unit
C_{IN}	Input capacitance (SDA)			8	pF
C_{IN}	Input capacitance (other pins)			6	pF
Z_L	Input impedance (\overline{WC})	$V_{IN} < 0.3 V_{CC}$	30		k Ω
Z_H		$V_{IN} > 0.7V_{CC}$	400		k Ω

1. Sampled only, not 100% tested.

Table 11. DC characteristics (M24M01-R and M24M01-HR)

Symbol	Parameter	Test condition (in addition to those in Table 7)	Min.	Max.	Unit
I_{LI}	Input leakage current (E1, E2, SCL, SDA)	$V_{IN} = V_{SS}$ or V_{CC} device in Standby mode		± 2	μA
I_{LO}	Output leakage current	SDA in Hi-Z, external voltage applied on SDA: V_{SS} or V_{CC}		± 2	μA
I_{CC}	Supply current (Read)	$V_{CC} = 1.8 V$, $f_c = 400 kHz$ (rise/fall time < 50 ns)		0.8	mA
		$V_{CC} = 2.5 V$, $f_c = 400 kHz$ (rise/fall time < 50 ns)		1	mA
		$V_{CC} = 5.5 V$, $f_c = 400 kHz$ (rise/fall time < 50 ns)		2	mA
		$1.8 V < V_{CC} < 5.5 V$, $f_c = 1 MHz$ (rise/fall time < 50 ns)		2.5	mA
$I_{CC0}^{(1)}$	Supply current (Write)	During t_W , $1.8V < V_{CC} < 5.5V$		5	mA
I_{CC1}	Standby supply current	Device not selected ⁽²⁾ , $V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 1.8 V$		1	μA
		Device not selected ⁽²⁾ , $V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 2.5 V$		2	μA
		Device not selected ⁽²⁾ , $V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 5.5 V$		3	μA
V_{IL}	Input low voltage (SCL, SDA, \overline{WC})	$1.8 V \leq V_{CC} < 2.5 V$	-0.45	$0.25 V_{CC}$	V
		$2.5 V \leq V_{CC} \leq 5.5 V$	-0.45	$0.3 V_{CC}$	
V_{IH}	Input high voltage (SCL, SDA, \overline{WC})	$1.8 V \leq V_{CC} < 2.5 V$	$0.75V_{CC}$	$V_{CC}+1$	V
		$2.5 V \leq V_{CC} \leq 5.5 V$	$0.7V_{CC}$	$V_{CC}+1$	
V_{OL}	Output low voltage	$I_{OL} = 1.0 mA$, $V_{CC} = 1.8 V$		0.2	V
		$I_{OL} = 2.1 mA$, $V_{CC} = 2.5 V$		0.4	V
		$I_{OL} = 3.0 mA$, $V_{CC} = 5.5 V$		0.4	V

1. Characterized value, not tested in production.

2. The device is not selected after a power-up, a Read instruction (after the Stop condition), or after the completion of an internal write cycle t_W (t_W is triggered by the correct decoding of a Write instruction).

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Table 12. DC characteristics (M24M01-W)

Symbol	Parameter	Test condition (in addition to those in Table 8)	Min.	Max.	Unit
I_{LI}	Input leakage current (E1, E2, SCL, SDA)	$V_{IN} = V_{SS}$ or V_{CC} device in Standby mode		± 2	μA
I_{LO}	Output leakage current	SDA in Hi-Z, external voltage applied on SDA: V_{SS} or V_{CC}		± 2	μA
I_{CC}	Supply current (Read)	$V_{CC} = 2.5 V$, $f_c = 400 kHz$ (rise/fall time < 50 ns)		1	mA
		$V_{CC} = 5.5 V$, $f_c = 400 kHz$ (rise/fall time < 50 ns)		2	mA
		$2.5 V < V_{CC} < 5.5 V$, $f_c = 1 MHz$ (rise/fall time < 50 ns)		2.5	mA
$I_{CC0}^{(1)}$	Supply current (Write)	During t_W , $2.5 V < V_{CC} < 5.5 V$		5	mA
I_{CC1}	Standby supply current	Device not selected ⁽²⁾ , $V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 2.5 V$		5	μA
		Device not selected ⁽²⁾ , $V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 5.5 V$		5	μA
V_{IL}	Input low voltage (SCL, SDA, \overline{WC})	$2.5 V \leq V_{CC} \leq 5.5 V$	-0.45	$0.3 V_{CC}$	
V_{IH}	Input high voltage (SCL, SDA, \overline{WC})	$2.5 V \leq V_{CC} \leq 5.5 V$	$0.7 V_{CC}$	$V_{CC}+1$	
V_{OL}	Output low voltage	$I_{OL} = 2.1 mA$, $V_{CC} = 2.5 V$		0.4	V
		$I_{OL} = 3.0 mA$, $V_{CC} = 5.5 V$		0.4	V

1. Characterized value, not tested in production.

2. The device is not selected after a power-up, a Read instruction (after the Stop condition), or after the completion of an internal write cycle t_W (t_W is triggered by the correct decoding of a Write instruction).

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Table 13. AC characteristics at 400 kHz (M24M01-R and M24M01-W)

Test conditions specified in Table 7 and Table 8					
Symbol	Alt.	Parameter	Min.	Max.	Unit
f_C	f_{SCL}	Clock frequency		400	kHz
t_{CHCL}	t_{HIGH}	Clock pulse width high	600		ns
t_{CLCH}	t_{LOW}	Clock pulse width low	1300		ns
$t_{XH1XH2}^{(1)}$	t_R	Input signal rise time		300	ns
$t_{XL1XL2}^{(1)}$	t_F	Input signal fall time		300	ns
$t_{QL1QL2}^{(2)}$	t_F	SDA (out) fall time	20	120	ns
t_{DXCH}	$t_{SU:DAT}$	Data in set up time	100		ns
t_{CLDX}	$t_{HD:DAT}$	Data in hold time	0		ns
t_{CLQX}	t_{DH}	Data out hold time	200		ns
$t_{CLQV}^{(3)(4)}$	t_{AA}	Clock low to next data valid (access time)	200	900	ns
$t_{CHDL}^{(5)}$	$t_{SU:STA}$	Start condition setup time	600		ns
t_{DLCL}	$t_{HD:STA}$	Start condition hold time	600		ns
t_{CHDH}	$t_{SU:STO}$	Stop condition setup time	600		ns
t_{DHDL}	t_{BUF}	Time between Stop condition and next Start condition	1300		ns
t_W	t_{WR}	Write time		5	ms
$t_{NS}^{(6)}$		Pulse width ignored (input filter on SCL and SDA)		100	ns

1. Input rise/fall time values recommended by the I²C-bus specification in Standard mode (100 kHz mode). The M24xxx devices accept these maximum input rise/fall times when running at a higher clock frequency provided that these rise/fall times are compatible with all the other timing conditions defined in this AC table.
2. The SDA(out) rise time is not defined by the M24xxx, it is defined by the application pull-up resistor (connected on the SDA line) and, therefore, it is not specified in this table.
3. To avoid spurious Start and Stop conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
4. t_{CLQV} is the time (from the falling edge of SCL) required by the SDA bus line to reach $0.8V_{CC}$ in a compatible way with the I²C specification (which specifies $t_{SU:DAT}(\min) = 100$ ns), assuming that the $R_{bus} \times C_{bus}$ time constant is less than 500 ns (as specified in [Figure 5](#)).
5. For a reStart condition, or following a Write cycle.
6. Characterized only, not tested in production.

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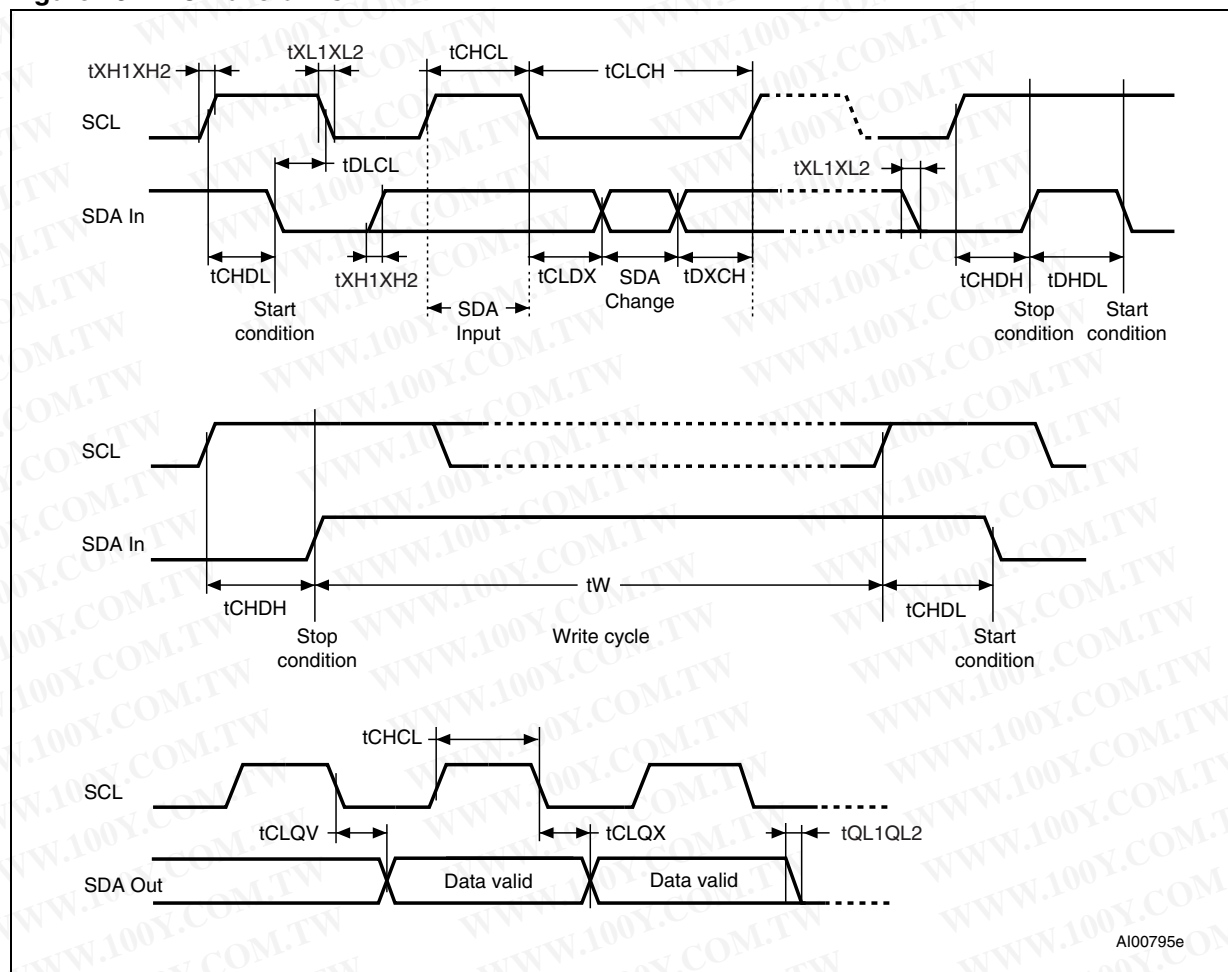
Table 14. AC characteristics at 1 MHz (M24M01-HR)

Test conditions specified in Table 7					
Symbol	Alt.	Parameter	Min.	Max.	Unit
f_C	f_{SCL}	Clock frequency	0	1	MHz
t_{CHCL}	t_{HIGH}	Clock pulse width high	300	-	ns
t_{CLCH}	t_{LOW}	Clock pulse width low	400	-	ns
$t_{XH1XH2}^{(1)}$	t_R	Input signal rise time	-	120	ns
$t_{XL1XL2}^{(1)}$	t_F	Input signal fall time	-	120	ns
$t_{QL1QL2}^{(2)(3)}$	t_F	SDA (out) fall time	-	120	ns
t_{DXCH}	$t_{SU:DAT}$	Data in setup time	80	-	ns
t_{CLDX}	$t_{HD:DAT}$	Data in hold time	0	-	ns
t_{CLQX}	t_{DH}	Data out hold time	50	-	ns
$t_{CLQV}^{(4)(5)}$	t_{AA}	Clock low to next data valid (access time)	50	500	ns
$t_{CHDL}^{(6)}$	$t_{SU:STA}$	Start condition setup time	250	-	ns
t_{DLCL}	$t_{HD:STA}$	Start condition hold time	250	-	ns
t_{CHDH}	$t_{SU:STO}$	Stop condition setup time	250	-	ns
t_{DHDL}	t_{BUF}	Time between Stop condition and next Start condition	500	-	ns
t_W	t_{WR}	Write time	-	5	ms
$t_{NS}^{(2)}$		Pulse width ignored (input filter on SCL and SDA)	-	50	ns

1. Input rise/fall time values recommended by the Fast-mode Plus I²C-bus specification. The M24xxx devices accept longer input rise/fall times provided that these rise/fall times are compatible with all other timing conditions defined in this AC table.
2. Characterized only, not tested in production.
3. The SDA(out) rise time is not defined by the M24xxx, it is defined by the application pull-up resistor (connected on the SDA line) and, therefore, it is not specified in this table.
4. To avoid spurious Start and Stop conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
5. t_{CLQV} is the time (from the falling edge of SCL) required by the SDA bus line to reach 0.8V_{CC}, assuming that the $R_{bus} \times C_{bus}$ time constant is within the range defined in Figure 6.
6. For a reStart condition, or following a Write cycle.

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Figure 13. AC waveforms

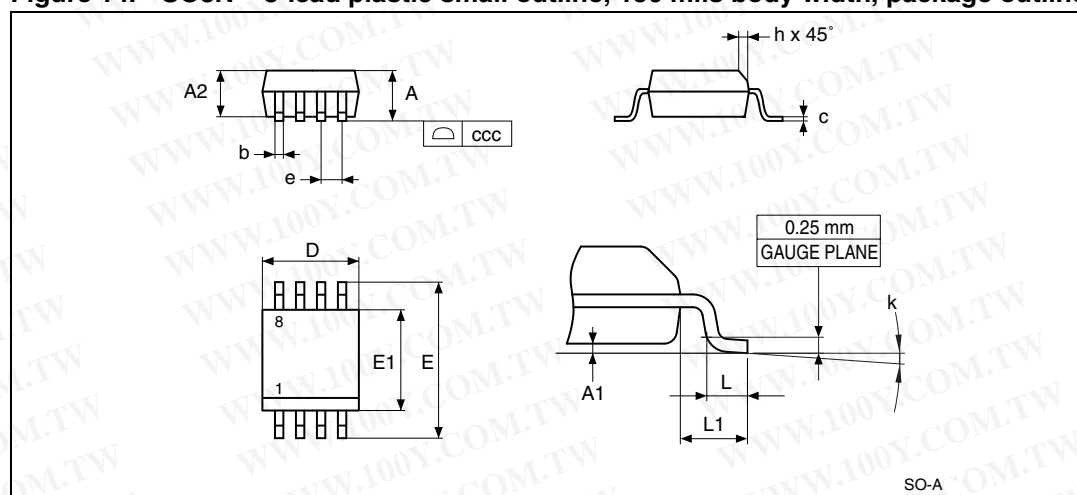


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7 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

Figure 14. SO8N – 8-lead plastic small outline, 150 mils body width, package outline

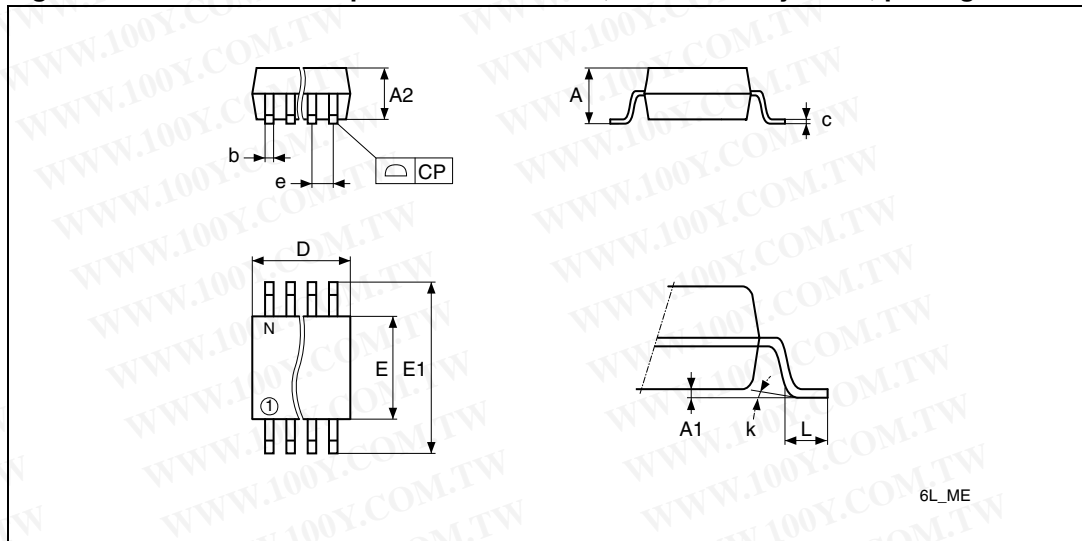


1. Drawing is not to scale.

Table 15. SO8N – 8-lead plastic small outline, 150 mils body width, package data

Symbol	millimeters			inches ⁽¹⁾		
	Typ	Min	Max	Typ	Min	Max
A			1.75			0.0689
A1		0.1	0.25		0.0039	0.0098
A2		1.25			0.0492	
b		0.28	0.48		0.011	0.0189
c		0.17	0.23		0.0067	0.0091
ccc			0.1			0.0039
D	4.9	4.8	5	0.1929	0.189	0.1969
E	6	5.8	6.2	0.2362	0.2283	0.2441
E1	3.9	3.8	4	0.1535	0.1496	0.1575
e	1.27	-	-	0.05	-	-
h		0.25	0.5		0.0098	0.0197
k		0°	8°		0°	8°
L		0.4	1.27		0.0157	0.05
L1	1.04			0.0409		

1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 15. SO8W – 8-lead plastic small outline, 208 mils body width, package outline

1. Drawing is not to scale.
2. The '1' that appears in the top view of the package shows the position of pin 1 and the 'N' indicates the total number of pins.

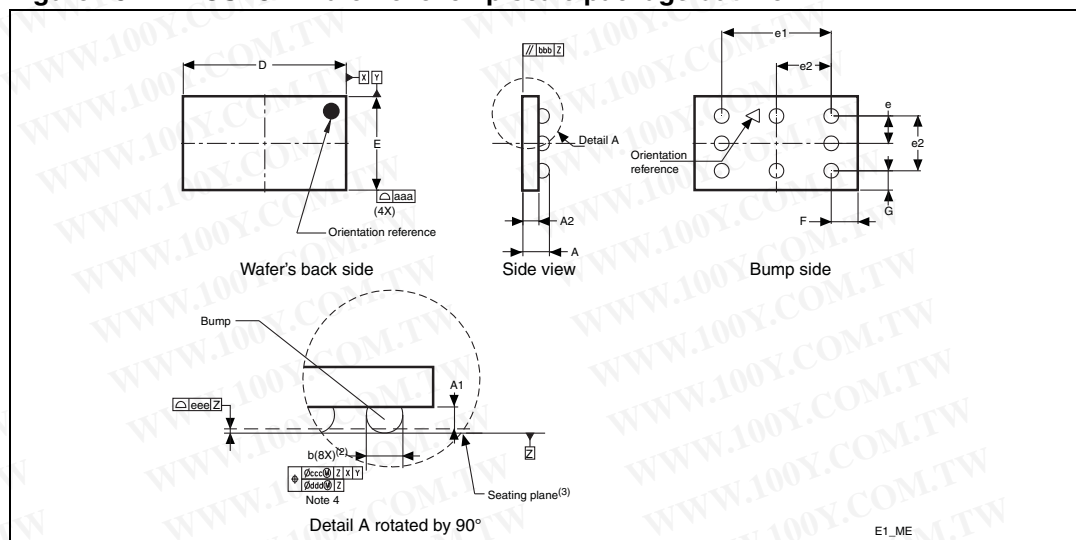
Table 16. SO8W – 8-lead plastic small outline, 208 mils body width, package mechanical data

Symbol	millimeters			inches ⁽¹⁾		
	Typ	Min	Max	Typ	Min	Max
A			2.5			0.0984
A1		0	0.25		0	0.0098
A2		1.51	2		0.0594	0.0787
b	0.4	0.35	0.51	0.0157	0.0138	0.0201
c	0.2	0.1	0.35	0.0079	0.0039	0.0138
CP			0.1			0.0039
D			6.05			0.2382
E		5.02	6.22		0.1976	0.2449
E1		7.62	8.89		0.3	0.35
e	1.27	-	-	0.05	-	-
k		0°	10°		0°	10°
L		0.5	0.8		0.0197	0.0315
N		8			8	

1. Values in inches are converted from mm and rounded to 4 decimal digits.

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Figure 16. WLCSP8 – Wafer level chip scale package outline



1. Drawing is not to scale and corresponds to preliminary data.
2. The dimension is measured at the maximum bump diameter parallel to primary datum Z.
3. The primary datum Z and seating plane are defined by the spherical crowns of the bump.
4. Bump position designation per JESD 95-1, SPP-010.

Table 17. WLCSP8 – Wafer level chip scale package mechanical data⁽¹⁾

Symbol	millimeters			inches ⁽²⁾		
	Typ	Min	Max	Typ	Min	Max
A	0.580	0.555	0.605	0.0228	0.0219	0.0238
A1	0.230			0.0091		
A2	0.350			0.0138		
b	0.322			0.0127		
D	3.570		3.685	0.1406		0.1451
E	2.050		2.165	0.0807		0.0852
e	0.600			0.0236		
e1	2.400			0.0945		
e2	1.200			0.0472		
F	0.585			0.0230		
G	0.424			0.0167		
aaa	0.110			0.0043		
bbb	0.110			0.0043		
ccc	0.110			0.0043		
ddd	0.060			0.0024		
eee	0.060			0.0024		
N (number of bumps)	8					

1. Preliminary data.
2. Values in inches are converted from mm and rounded to 4 decimal digits.

8 M24M01-R die description

Caution: As EEPROM cells loose their charge (and so their binary value) when exposed to ultra violet (UV) light, EEPROM dice delivered in wafer form by STMicroelectronics must never be exposed to UV light.

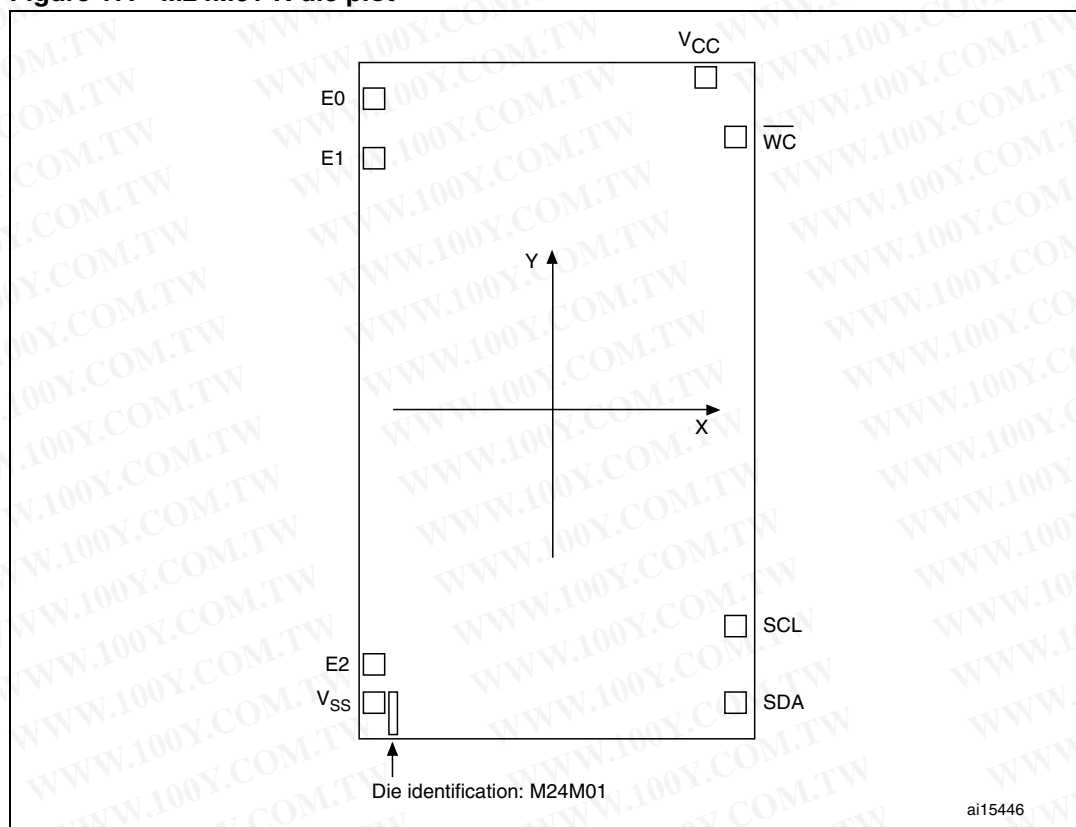
Product M24M01-A

- Wafer size 203 mm (8 inches)
- Die identification M24M01, processed in the Rousset fab

Die Layout

- Die size (X × Y) 2085 × 3605 μm (including scribe line)
- Scribe line 80.0 × 80.0 μm
- Pad opening 90 × 90 μm
- DI Die identification (at the position shown in [Figure 17](#))
- Pads Pad contacts (at the positions shown in [Figure 17](#) and [Table 18](#))

Figure 17. M24M01-R die plot



1. Refer to [Table 18: Pad coordinates](#) for the pad locations.

Table 18. Pad coordinates⁽¹⁾

Signal	X (μm)	Y (μm)	Pads
V _{CC}	784.02	1683	8
WC	922	1383.1	7
SCL	922.78	-1171.22	6
SDA	922.78	-1450.14	5
V _{SS}	-920.06	-1548.98	4
E2	-920.06	-1358.7	3
E1	-922.8	1270.7	2
E0	-922.8	1563.02	1

1. Pad locations are measured relative to the die center (where X and Y are the horizontal and vertical axis, respectively, measured in μm). Refer to [Figure 17](#).

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9 Part numbering

Table 19. Ordering information scheme (M24M01-x products sold in packages)

Example: M24M01 – H R MN 6 T P /A

Device type

M24 = I²C serial access EEPROM

Device function

M01 = 1 Mbit (256 Kb × 8 bits)

Clock frequency

Blank: f_C max = 400 kHz

H: f_C max = 1 MHz

Operating voltage

W = V_{CC} = 2.5 V to 5.5 V

R = V_{CC} = 1.8 V to 5.5 V

Package

MN = SO8 (150 mils width)

MW = SO8 (208 mils width)

CS = WLCSP

Device grade

6 = Industrial temperature range, –40 to 85 °C.

Device tested with standard test flow

3 = Automotive: device tested with high reliability certified flow⁽¹⁾ over –40 to 125 °C

Option

blank = standard packing

T = tape and reel packing

Plating technology

P or G = ECOPACK® (RoHS compliant)

Process⁽²⁾

A = F8L

1. ST strongly recommends the use of automotive grade devices for use in automotive environments. The high reliability certified flow (HRCF) is described in the quality note QNEE9801. Please ask your nearest ST sales office for a copy.
2. The Process letter only concerns grade 3 devices and WLCSP devices.

Table 20. Ordering information scheme (M24M01-R sold as bare dice)

Example:	M24M01	–	R	A	W	21	/90
Device type							
M24 = I ² C serial access EEPROM							
Device function							
M01 = 1 Mbit (256 Kb × 8 bits)							
Clock frequency							
Blank: f _C max = 400 kHz							
Operating voltage							
R = V _{CC} = 1.8 V to 5.5 V							
Process letter							
A = F8L							
Delivery form							
W = unsawn wafer							
Wafer thickness							
21 = 280 μm							
Temperature range							
/90 = –40 to 85 °C							

For a list of available options (speed, package, etc.) or for further information on any aspect of the devices, please contact your nearest ST sales office.

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Table 21. Available M24M01-x products (package, voltage range, frequency, temperature grade)

Package	M24M01-HR 1.8 V to 5.5 V at 1 MHz	M24M01-R 1.8 V to 5.5 V at 400 kHz	M24M01-W 2.5 V to 5.5 V at 400 kHz
SO8N (MN)	Range 6	Range 6	Range 3
SO8W (MW)	-	Range 6	-
Wafer	-	Range 6	-
WLCSP (CS)	-	Range 6	-

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10 Revision history

Table 22. Document revision history

Date	Revision	Changes
07-Dec-2006	1	Initial release.
02-Oct-2007	2	Document status promoted from Preliminary Data to full Datasheet. Section 2.6: Supply voltage (VCC) updated. Note 1 updated to latest standard revision below Table 6: Absolute maximum ratings . V_{IL} , V_{IH} modified and, rise/fall time corrected in Test conditions in Table 11: DC characteristics (M24M01-R and M24M01-HR) . Package values in inches calculated from mm and rounded to 4 decimal digits (note added below package mechanical data tables in Section 7: Package mechanical data .
26-Nov-2007	3	1 MHz maximum clock frequency added: – Figure 6: M24M01-HR – Maximum Rbus value versus bus parasitic capacitance (Cbus) for an I2C bus at maximum frequency fC = 1MHz – Table 14: AC characteristics at 1 MHz (M24M01-HR) added. t_{NS} moved from Table 10: Input parameters to Table 13: AC characteristics at 400 kHz (M24M01-R and M24M01-W) . Note removed below Table 10 . In Table 13 , t_{CH1CH2} , t_{CL1CL2} and t_{DL1DL2} removed, t_{XH1XH2} , t_{XL1XL2} added, t_{DL1DL2} max modified, notes modified. Figure 5: M24M01-R/M24M01-W – Maximum Rbus value versus bus parasitic capacitance (Cbus) for an I2C bus at maximum frequency fC = 400 kHz modified. Figure 13: AC waveforms modified. Small text changes.
18-Mar-2008	4	M24M01-HR root part number added. Small text changes. Figure 6: M24M01-HR – Maximum Rbus value versus bus parasitic capacitance (Cbus) for an I2C bus at maximum frequency fC = 1MHz modified. Most significant address bits modified in Section 3.8: Page Write on page 15 . Test conditions modified for I_{LI} , I_{CC} and V_{OL} in Table 11: DC characteristics (M24M01-R and M24M01-HR) . TW and TNS values corrected in Table 13: AC characteristics at 400 kHz (M24M01-R and M24M01-W) . Cross-reference corrected in Note 5 below Table 14: AC characteristics at 1 MHz (M24M01-HR) .

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Table 22. Document revision history (continued)

Date	Revision	Changes
02-Sep-2008	5	<p>Added: M24M01-W part number in device grade 3 temperature range (see Table 8: Operating conditions (M24M01-W), Table 12: DC characteristics (M24M01-W) and Table 19: Ordering information scheme (M24M01-x products sold in packages)).</p> <p>M24M01-R offered as a bare die (see Section 8: M24M01-R die description and Table 20: Ordering information scheme (M24M01-R sold as bare dice)).</p> <p>In Table 13: AC characteristics at 400 kHz (M24M01-R and M24M01-W), Note 1 modified, Note 2 added, t_{XH1XH2}, t_{XL1XL2} and t_{DL1DL2} values modified.</p> <p>In Table 14: AC characteristics at 1 MHz (M24M01-HR), Note 1 modified, Note 3 added, t_{XH1XH2}, t_{XL1XL2} and t_{DL1DL2} values modified.</p> <p>t_{CHDX}, t_{DL1DL2} and t_{DXCX} changed to t_{CHDL}, t_{QL1QL2} and t_{DXCH}, respectively (see Table 13, Table 14 and Figure 13).</p> <p>Table 21: Available M24M01-x products (package, voltage range, frequency, temperature grade) added.</p> <p>Small text changes.</p>
12-Mar-2009	6	<p>WLCSP8 package added (see Figure 3: WLCSP8 connections and Section 7: Package mechanical data).</p> <p>Section 2.6: Supply voltage (VCC) updated.</p> <p>I_{OL} added to Table 6: Absolute maximum ratings.</p> <p>V_{RES} added to Table 11: DC characteristics (M24M01-R and M24M01-HR) and Table 12: DC characteristics (M24M01-W).</p> <p>ECOPACK text updated.</p>
26-Jun-2009	7	<p>Section : Features updated.</p> <p>NC pin changed to DU in Figure 2: SO connections.</p> <p>Device select code Chip enable address bits updated in Section 2.3.</p> <p>Internal reset threshold modified in Section 2.6.3: Device reset.</p> <p>Figure 6: M24M01-HR – Maximum Rbus value versus bus parasitic capacitance (Cbus) for an I2C bus at maximum frequency fC = 1MHz updated.</p> <p>V_{RES} removed, and I_{CC1} conditions modified in Table 11: DC characteristics (M24M01-R and M24M01-HR), and Table 12: DC characteristics (M24M01-W). V_{RES} removed from Table 12: DC characteristics (M24M01-W).</p> <p>t_{XH1XH2} updated in Table 13: AC characteristics at 400 kHz (M24M01-R and M24M01-W). t_{XH1XH2} updated, and Note 5 updated in Table 14: AC characteristics at 1 MHz (M24M01-HR).</p> <p>Command replaced by instruction in the whole document.</p>

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